



#### **60V N-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

BV <sub>DSS</sub>	RDS(ON) Max	I <sub>D</sub> T <sub>C</sub> = +25°C
60V	$8.3m\Omega$ @ $V_{GS} = 10V$	52.1A
60 V	$12.5 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{V}$	42.4A

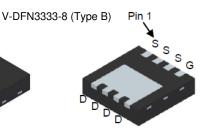
### **Features and Benefits**

- 100% Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
- High Conversion Efficiency
- Low R<sub>DS(ON)</sub> Minimizes On State Losses
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/

### **Description and Applications**

This new generation N-channel enhancement mode MOSFET is designed to minimize  $R_{DS(ON)}$  yet maintain superior switching performance. This device is ideal for use in notebook battery power management and load switch.

- Synchronous Rectifier
- Power Management Functions
- DC-DC Converters

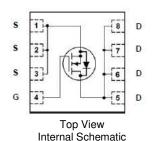


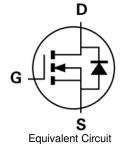
Top View

**Bottom View** 

#### **Mechanical Data**

- Case: V-DFN3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Below Diagram
- Terminals: Finish—NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (4)
- Weight: 0.027 grams (Approximate)





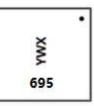
**Ordering Information** (Note 4)

Part Number	Case	Packaging
DMT69M5LCG-7	V-DFN3333-8 (Type B)	2,000/Tape & Reel
DMT69M5LCG -13	V-DFN3333-8 (Type B)	3,000/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- $4. For packaging details, go to our website at \ https://www.diodes.com/design/support/packaging/diodes-packaging/. \\$

# **Marking Information**



695 = Product Type Marking Code YWX = Date Code Marking

Y = Year (ex: 0 = 2020)

W = Week (ex: a = week 27; z represents week 52 and 53)

X = Internal Code (ex: U = Monday)

Date Code Key

Date Gode Key												
Year	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030	2031
Code	0	1	2	3	4	5	6	7	8	9	0	1
					1			1				
Week	1-26			27-52			53					
Code	A-Z			a-z			Z					
Internal Code	Sur	, [	Mon		Tue	W	ed	Thu		Fri		Sat
										· · ·		7
Code			U		V	١ ١	N I	Χ.		Y		_



# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	60	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
Continuous Drain Current, Vgs = 10V (Note 6)	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	ΙD	14.6 11.7	А
Continuous Drain Current, Vgs = 10V (Note 7)	ΙD	52.1 41.7	А		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	Ірм	208	Α		
Maximum Continuous Body Diode Forward Current	Is	52	Α		
Pulsed Body Diode Forward Current (10µs Pulse, I	I <sub>SM</sub>	208	Α		
Avalanche Current, L = 0.1mH	las	27.4	Α		
Avalanche Energy, L = 0.1mH	•		Eas	37.5	mJ

### Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	PD	1.37	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R <sub>θ</sub> JA	91	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	P <sub>D</sub>	2.64	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	47.3	°C/W
Thermal Resistance, Junction to Case (Note 7)		Rejc	3.7	°C/W
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

#### Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)					•	•
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 48V, V_{GS} = 0V$
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.4	_	2.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
Static Drain-Source On-Resistance	D	_	6.1	8.3	mΩ	V <sub>G</sub> S = 10V, I <sub>D</sub> = 13.5A
Static Drain-Source On-nesistance	Rds(on)	-	8.7	12.5	11177	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 11.5A
Diode Forward Voltage	$V_{SD}$	_	0.7	1.2	V	V <sub>G</sub> S = 0V, I <sub>S</sub> = 1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	Ciss	_	1406	_		V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V, f = 1MHz
Output Capacitance	Coss		540		pF	
Reverse Transfer Capacitance	Crss	1	52	_		I = I IVII IZ
Gate Resistance	Rg	_	1.85	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	28.4	_		
Total Gate Charge (VGS = 4.5V)	Qg	-	15.4	_	nC	V 00V I 10 5A
Gate-Source Charge	Qgs	_	2.4	_	110	$V_{DS} = 30V, I_{D} = 13.5A$
Gate-Drain Charge	Qgd	_	9.0	_		
Turn-On Delay Time	td(ON)	_	10.5	_		
Turn-On Rise Time	t <sub>R</sub>	_	49.0	_		$V_{DD} = 30V, V_{GS} = 10V,$
Turn-Off Delay Time	tD(OFF)	_	30.9	_	ns	$I_D = 13.5A, R_G = 6\Omega$
Turn-Off Fall Time	tF	_	79.5	_		
Reverse Recovery Time	t <sub>RR</sub>		26.7		ns	1 10 54 11/14 0004/11
Reverse Recovery Charge	Qrr	_	44.8	_	nC	I <sub>F</sub> = 13.5A, di/dt = 300A/μs

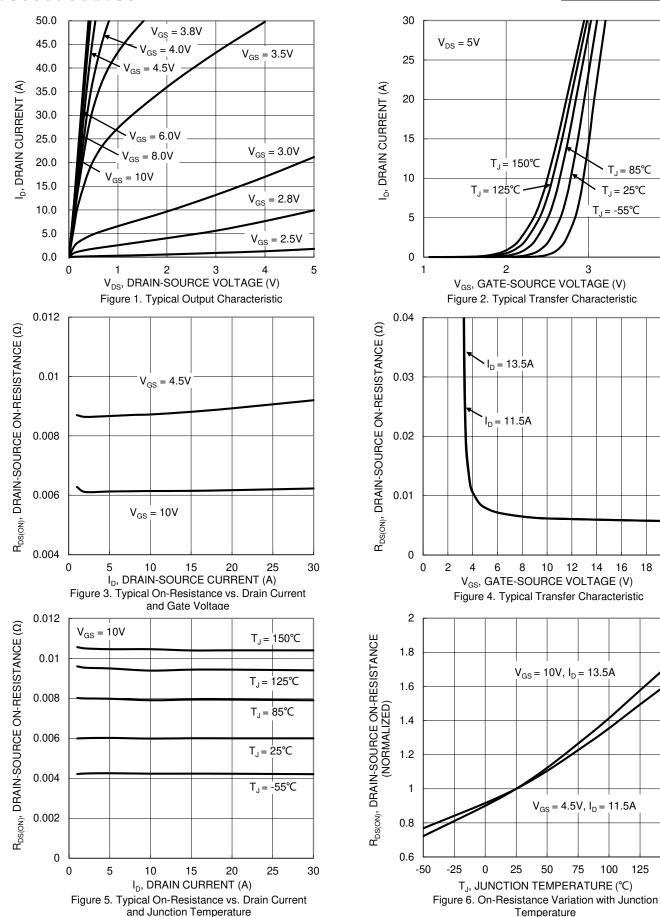
<sup>5.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

S. Device mounted on FR-4 substrate PC board, 2oz copper, with flinch square copper plate.
Thermal resistance from junction to soldering point (on the exposed drain pad).
Short duration pulse test used to minimize self-heating effect.

<sup>9.</sup> Guaranteed by design. Not subject to product testing.







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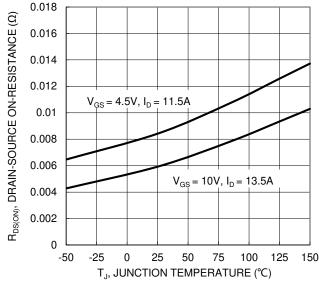
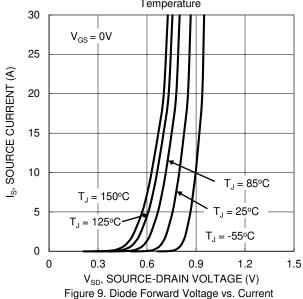


Figure 7. On-Resistance Variation with Junction Temperature



10 8  $V_{GS}(V)$ 4  $V_{DS} = 30V, I_{D} = 13.5A$ 2 0 5 30 0 10 15 20 25  $Q_g$  (nC) Figure 11. Gate Charge

3  $V_{GS(TH)},$  GATE THRESHOLD VOLTAGE (V) 2.5  $I_D = 1mA$ 2 1.5  $I_{D} = 250 \mu A$ 1 0.5 0 -50 -25 0 25 50 75 100 125 150 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature

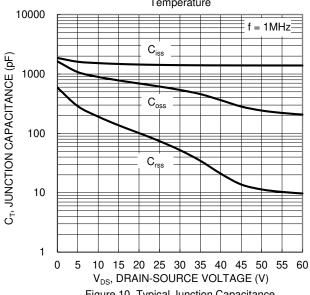


Figure 10. Typical Junction Capacitance

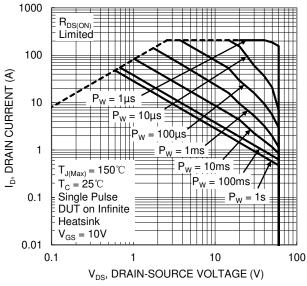


Figure 12. SOA, Safe Operation Area



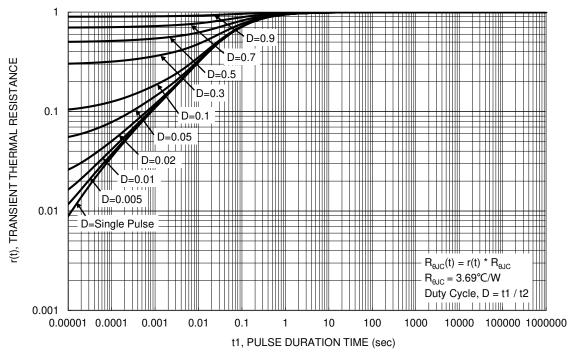


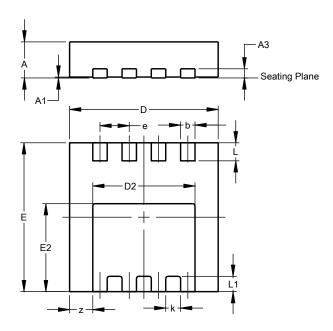
Figure 13. Transient Thermal Resistance



### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### V-DFN3333-8 (Type B)

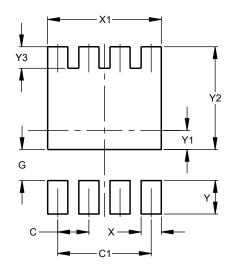


V-DFN3333-8								
(Type B)								
Dim	Min Max Ty							
Α	0.75	0.85	0.80					
A1	0.00	0.05	0.02					
A3	-		0.203					
b	0.27	0.37	0.32					
D	3.25	3.35	3.30					
D2	2.17	2.37	2.27					
Е	3.25	3.35	3.30					
<b>E2</b>	1.85	2.05	1.95					
е			0.65					
k			0.33					
L	0.35	0.45	0.40					
L1	-		0.34					
Z	-		0.515					
All Dimensions in mm								

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### V-DFN3333-8 (Type B)



Dimensions	value (in mm)
С	0.650
C1	1.950
G	0.650
X	0.420
X1	2.370
Υ	0.700
Y1	0.400
Y2	2.150
Y3	0.450



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